

SEMITOP® 2

MOSFET Module

SK 60 MD 10

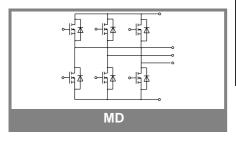
Target Data

Features

- · Compact design
- · One screw mounting
- · Heat transfer and isolation through direct copper bonding aluminium oxide ceramic (DBC)
- Trench-gate technologyShort internal connections and low inductance case

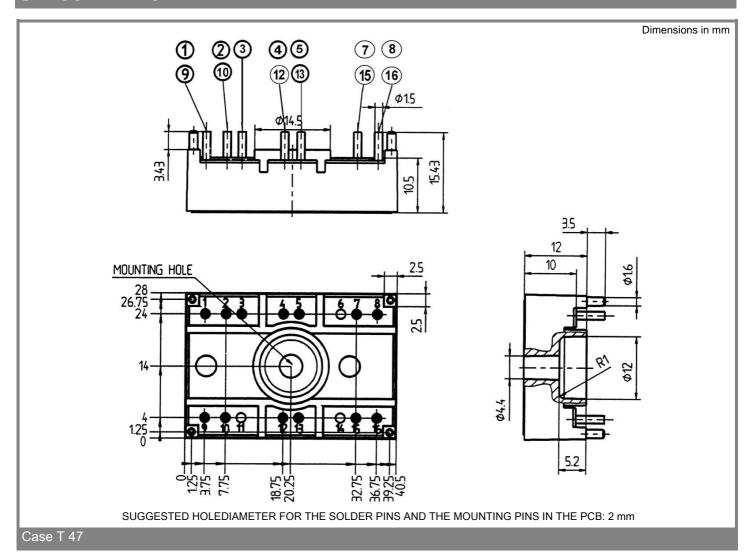
Typical Applications

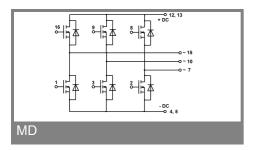
- Low switched mode power supplies
- DC servo drives
- UPS
- 1) Maximum PCB temperature, at pins contact, = 85°C



Absolute Maximum Ratings $T_s = 25 ^{\circ}\text{C}$, unless otherwise specified								
Symbol	Conditions	Values	Units					
MOSFET								
V_{DSS}		100	V					
V_{GSS}		± 20	V					
I _D	$T_s = 25 (80) ^{\circ}C; 1)$	80 (60)	Α					
I _{DM}	$t_p < 1 \text{ ms; } T_s = (80) \text{ °C; } 1)$	(120)	Α					
T _j		- 40 + 150	°C					
Inverse diode								
I _F = - I _D	T _s = 25 (80) °C;	80 (60)	Α					
$I_{FM} = -I_{DM}$	$t_p < 1 \text{ ms; } T_s = (80) \text{ °C;}$	(120)	Α					
T _j		- 40 + 150	°C					
Freewheeling CAL diode								
$I_F = -I_D$	$T_s = {^{\circ}C}$		Α					
T _j			°C					
T _{stg}		- 40 + 125	°C					
T _{sol}	Terminals, 10 s	260	°C					
V _{isol}	AC, 1 min (1s)	2500 / 3000	V					

Characteristics		T _s = 25 °C,	T _s = 25 °C, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units		
MOSFET		•					
$V_{(BR)DSS}$ $V_{GS(th)}$ I_{DSS} I_{GSS}	$\begin{aligned} &V_{GS} = 0 \; V, \; I_{D} = 5,6 \; mA \\ &V_{GS} = V_{DS}; \; I_{D} = 5,6 \; mA \\ &V_{GS} = 0 \; V; \; V_{DS} = V_{DSS}; \; T_{j} = 25 \; ^{\circ}C \\ &V_{GS} = \pm 20 V; \; V_{DS} = 0 \; V \end{aligned}$	100 2,5	3,3	100 100	V V μA nA		
R _{DS(on)}	$I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$ $I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}; T_j = 125 \text{ °C}$			7,5 13,5	mΩ mΩ		
R _{DS(on)}	per MOSFET			10,0	pF		
C _{iss} C _{oss} C _{rss}	under following conditions: V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz		9,1 1,8 1,6		nF nF nF		
L _{DS}					nH		
t _{d(on)} t _r	under following conditions: V _{DD} = 50 V; V _{GS} = 10 V; I _D = 50 A		300 150		ns ns		
$t_{d(off)}$ t_{f}	$R_G = 56 \Omega$		1600 160		ns ns		
R _{th(j-s)}	per MOSFET (per module)			1,1	K/W		
Inverse d	liode						
V_{SD}	I _F = 50 A; V _{GS} = 0 V; T _i = 50 °C		0,9		V		
I _{RRM} Q _{rr} t _{rr}	under following conditions: $I_F = 50 \text{ A}; T_{vj} = 25 \text{ °C}; R_G = 56 \Omega$ $V_R = 65 \text{ A}; \text{ di/dt} = 100 \text{ A/µs}$		24 0,9 70		Α μC ns		
	eling diode				1		
V _F	I _F = A; V _{GS} = V				V		
I _{RRM} Q _{rr}	under following conditions: $I_F = A; T_{vj} = {}^{\circ}C$				Α μC		
t _{rr}	$V_r = A$; di/dt = A/ μ s				ns		
Mechanic		i		0	Lara		
M1 w	mounting torque		20	2	Nm g		
Case	SEMITOP® 2		T 47				





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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